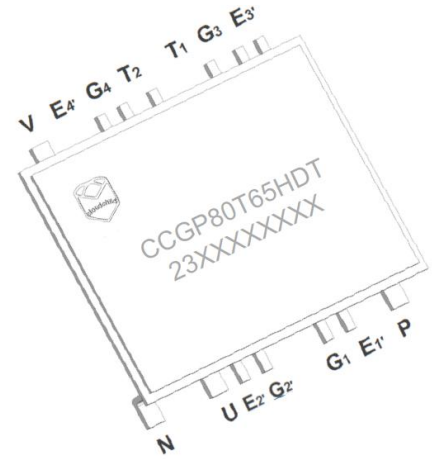




DPIM Encapsulate IGBT MODULE

CCGP80T65HDT Planar-FS IGBT module

VCES	VCEsat		I _{cnom} /I _{CRM}
	650V	T _{vj} =25°C	
T _{vj} =150°C		1.8V	



DESCRIPTION

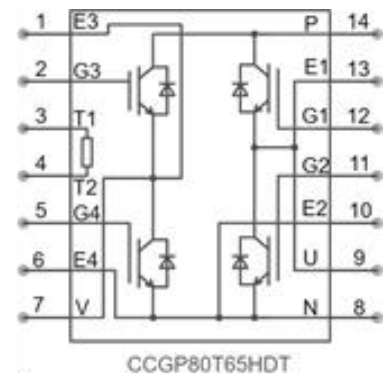
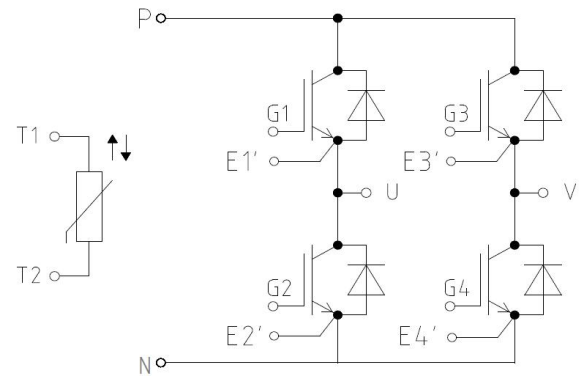
The DPIM module with Trench/Fieldstop IGBT and Emitter Controlled diode and NTC.

FEATURES

- Low inductive design
- High Creepage and Clearance Distances
- RoHS compliant
- Rugged mounting due to integrated mounting clamps
- AQC324 Qualified

APPLICATIONS

- Automotive Applications
- High Frequency Switching Application
- DC/DC converter
- Auxiliary Inverters
- Hybrid Electrical Vehicles (H)EV
- Inductive Heating and Welding



CHARACTERISTICS VALUES

MAXIMUM RATED VALUES(IGBT)

Parameter	Symbol	Conditions	Values	Units
Collector-emitter voltage	V_{CES}	$T_{vj}=25^{\circ}\text{C}$, $V_{GE}=0\text{V}$	650	V
Continuous collector current	I_{cnom}	$T_c=100^{\circ}\text{C}$, $T_{vjmax}=175^{\circ}\text{C}$	75	A
Repetitive peak collector current	I_{CRM}	$t_p=1\text{ms}$, $T_{vj}=25^{\circ}\text{C}$	150	A
Gate-emitter peak voltage	V_{GES}	$T_{vj}=25^{\circ}\text{C}$	± 20	V
SC data	I_{SC}	$V_{GE}\leq 15\text{V}$, $V_{CC}=800\text{V}$ $V_{CEmax}=V_{CES}-L_{sCE} * di/dt$ $t_p\leq 10\mu\text{s}$, $T_{vj}=150^{\circ}\text{C}$	380	A
Total power dissipation	P_{tot}	$T_c=25^{\circ}\text{C}$, $T_{vj max}=175^{\circ}\text{C}$	200	W

CHARACTERISTICS VALUES(IGBT)

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Collector-emitter breakdown voltage	V_{BRCES}	$V_{GE}=0\text{V}$, $I_C=100\mu\text{A}$	650			V
Collector-emitter saturation voltage	$V_{CE sat}$	$I_C=80\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=25^{\circ}\text{C}$		1.70	2.0	V
		$I_C=80\text{A}$, $V_{GE}=15\text{V}$, $T_{vj}=150^{\circ}\text{C}$		1.80		V
Gate-emitter threshold voltage	V_{GEth}	$V_{CE}=V_{GE}$, $I_C=3\text{mA}$, $T_{vj}=25^{\circ}\text{C}$	4.8	5.5	6.2	V
Gate charge	Q_G	$V_{GE}=-8\text{V}\dots+15\text{V}$		0.8		μC
Integrated gate resistor	R_G	$T_{vj}=25^{\circ}\text{C}$		5		Ω
Input capacitance	C_{ies}	$T_{vj}=25^{\circ}\text{C}$, $f=1\text{MHz}$, $V_{GE}=0\text{V}$, $V_{CE}=25\text{V}$		3.29		nF
Output capacitance	C_{oes}	$T_{vj}=25^{\circ}\text{C}$, $f=1\text{MHz}$, $V_{GE}=0\text{V}$, $V_{CE}=25\text{V}$		0.55		
Reverse transfer capacitance	C_{res}	$T_{vj}=25^{\circ}\text{C}$, $f=1\text{MHz}$, $V_{GE}=0\text{V}$, $V_{CE}=25\text{V}$		0.14		nF
Collector-emitter cut-off current	I_{CES}	$V_{CE}=650\text{V}$, $V_{GE}=0\text{V}$, $T_{vj}=25^{\circ}\text{C}$			4	μA
Gate-emitter leakage current	I_{GES}	$V_{CE}=0\text{V}$, $V_{GE}=20\text{V}$, $T_{vj}=25^{\circ}\text{C}$			200	nA
Turn-on delay time, inductive load	$t_{d on}$	$I_C=80\text{A}$, $V_{CE}=350\text{V}$, $V_{GE}=-8\text{V}/+15\text{V}$ $R_{Gon}=12\Omega$, $R_{Goff}=12\Omega$	$T_{vj}=25^{\circ}\text{C}$		152	ns
			$T_{vj}=150^{\circ}\text{C}$		155	ns
Rise time, inductive load	t_r		$T_{vj}=25^{\circ}\text{C}$		40	ns
			$T_{vj}=150^{\circ}\text{C}$		49	ns
Turn-off delay time, inductive load	$t_{d off}$		$T_{vj}=25^{\circ}\text{C}$		215	ns
			$T_{vj}=150^{\circ}\text{C}$		231	ns
Fall time, inductive load	t_f		$T_{vj}=25^{\circ}\text{C}$		57	ns
			$T_{vj}=150^{\circ}\text{C}$		102	ns
Turn-on energy loss per pulse	E_{on}		$T_{vj}=25^{\circ}\text{C}$		3.91	mJ
			$T_{vj}=150^{\circ}\text{C}$		4.23	mJ
Turn-off energy loss per pulse	E_{off}	$T_{vj}=25^{\circ}\text{C}$		1.83	mJ	
		$T_{vj}=150^{\circ}\text{C}$		1.97	mJ	

MAXIMUM RATED VALUES(FRD)

Parameter	Symbol	Conditions	Values	Units
Repetitive peak reverse voltage	V_{RRM}	$T_{vj}=25^{\circ}\text{C}$	650	V
Continuous forward current	I_F		80	A
Maximum repetitive forward current	I_{FRM}	Pulse, $t_p=1\text{ms}$, $T_{vj}=25^{\circ}\text{C}$	160	A
I^2t -value	I^2t	$V_R=0\text{V}$, $t_p=10\text{ms}$, $T_{vj}=125^{\circ}\text{C}$	500	A^2s
		$V_R=0\text{V}$, $t_p=10\text{ms}$, $T_{vj}=150^{\circ}\text{C}$	460	

CHARACTERISTICS VALUES(FRD)

Parameter	Symbol	Conditions	Values			Units	
			Min.	Typ.	Max.		
Breakdown voltage	$V_{(BR)}$	$I_R=100\mu\text{A}$, $T_{vj}=25^{\circ}\text{C}$	650			V	
Reverse current	I_R	$V_R=650\text{V}$, $T_{vj}=25^{\circ}\text{C}$			100	μA	
Forward voltage	V_F	$I_F=80\text{A}$, $V_{GE}=0\text{V}$	$T_{vj}=25^{\circ}\text{C}$		1.8	2.2	V
			$T_{vj}=150^{\circ}\text{C}$		1.75		V
Peak reverse recovery current	I_{RM}	$I_F=80\text{A}$, $V_R=350\text{V}$,	$T_{vj}=25^{\circ}\text{C}$		95		A
			$T_{vj}=150^{\circ}\text{C}$		110		A
Recovered charge	Q_r	$V_{GE}=-8\text{V}/+15\text{V}$, $di_F/dt=2300\text{A}/\mu\text{s}$,	$T_{vj}=25^{\circ}\text{C}$		3.7		μC
			$T_{vj}=150^{\circ}\text{C}$		7.0		μC
Reverse recovery energy	E_{rec}	$L_o=45\text{nH}$	$T_{vj}=25^{\circ}\text{C}$		0.9		mJ
			$T_{vj}=150^{\circ}\text{C}$		1.75		mJ

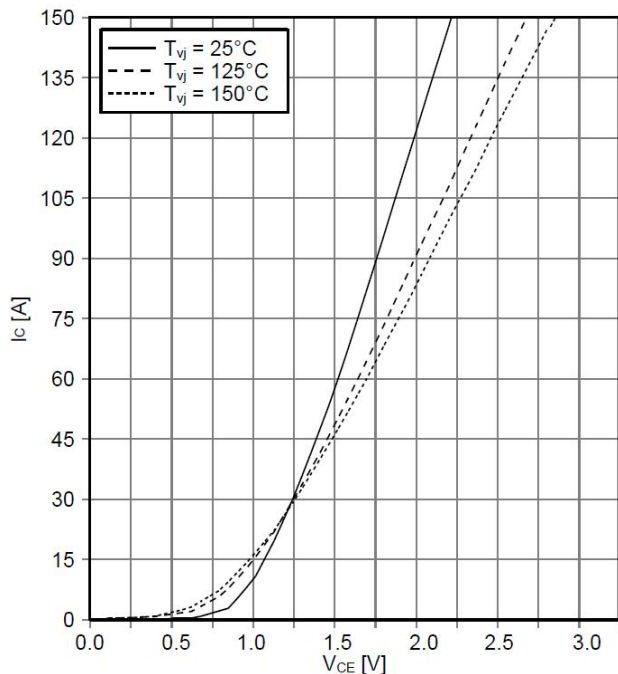
MODULE

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Maximum junction temperature	$T_{vj\text{max}}$				175	$^{\circ}\text{C}$
Temperature under switching conditions	$T_{vj\text{op}}$		-40		175	$^{\circ}\text{C}$
Storage temperature	T_{stg}		-40		175	$^{\circ}\text{C}$
IGBT, thermal resistance, junction to case	$R_{thjc\text{IGBT}}$	Per IGBT		0.75	0.85	K/W
Diode, thermal resistance, junction to case	$R_{thjc\text{Diode}}$	Per diode		0.60		K/W
Stray inductance module	L_{sCE}			15		nH
Module lead resistance, terminals-chip	R_{CC+EE}	$T_{vj}=25^{\circ}\text{C}$, per switch		0.55		m Ω
Isolation test voltage	V_{isol}	AC, RMS, $f=50\text{Hz}$, $t=1\text{min}$		2.5		kV
Creepage distance	ds	Terminal to terminal		17.0		mm
		Terminal to base		20.0		mm
Clearance distance in air	da	Terminal to terminal		17.0		mm
		Terminal to base		9.5		mm
Comperative tracking index	CTI			>200		
Soldering Temperature , for 10S(1.6mm from case)	-			220		$^{\circ}\text{C}$
Internal isolation	-	Basic insulation		Al_2O_3		-
Material of module baseplate	-			Cu		-
Dimensions	L x W x H			35.30x27.5x3.98		mm
Weight	G			27		g

CHARACTERISTICS DIAGRAMS

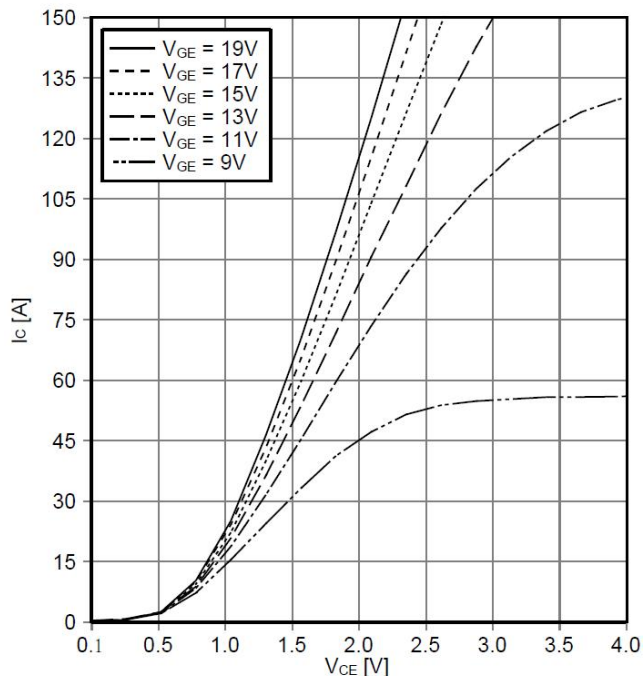
Output characteristic IGBT, Inverter(typical)

$I_C=f(V_{CE})$, $V_{GE}=15V$



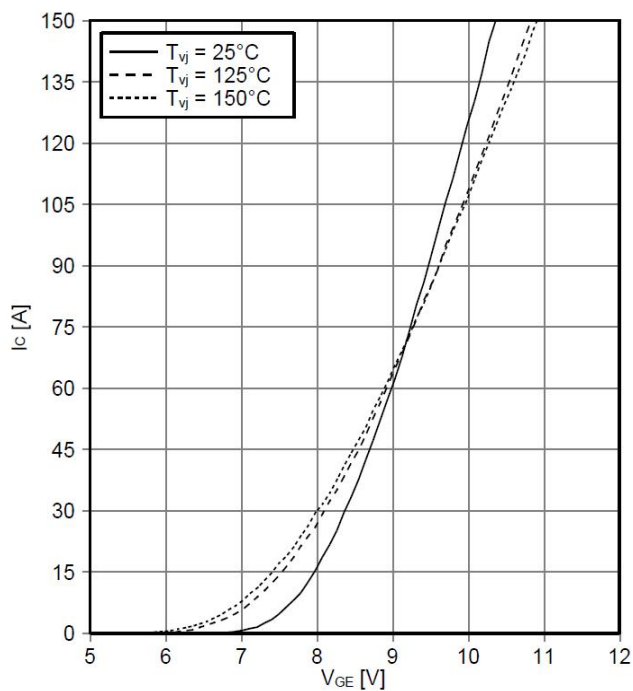
Output characteristic IGBT, Inverter(typical)

$I_C=f(V_{CE})$, $T_{vj}=150^\circ C$



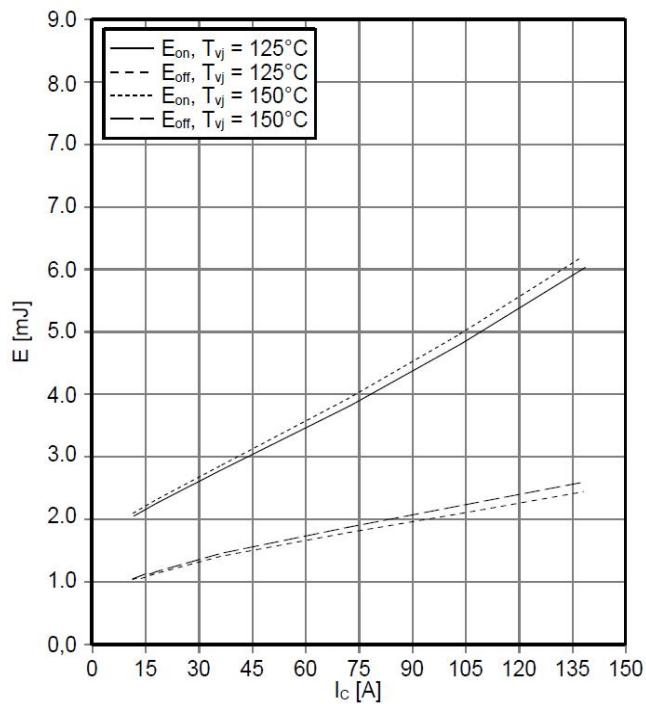
Transfer characteristic IGBT, Inverter(typical)

$I_C=f(V_{GE})$, $V_{CE}=20V$



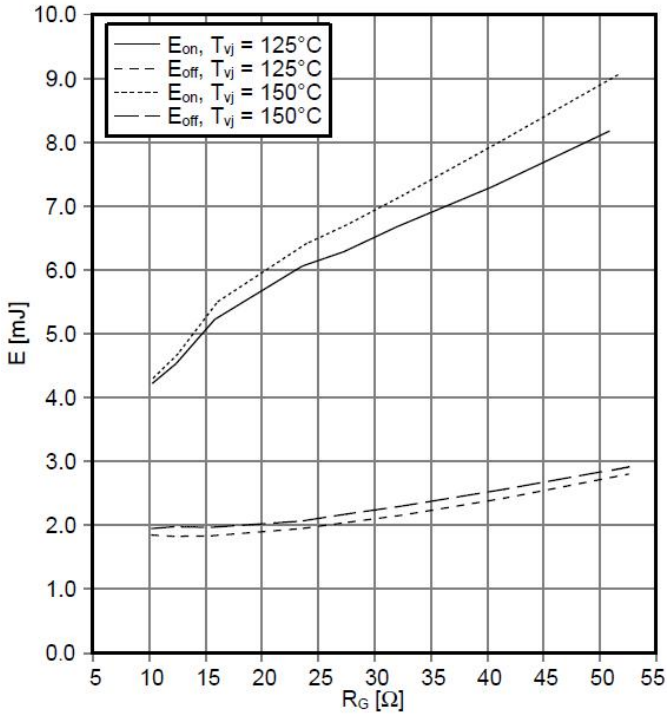
Switching losses IGBT, Inverter(typical)

$E_{on}=f(I_C)$, $E_{off}=f(I_C)$, $V_{GE}=\pm 15V$, $R_{Gon}=R_{Goff}=12\Omega$, $V_{CE}=350V$



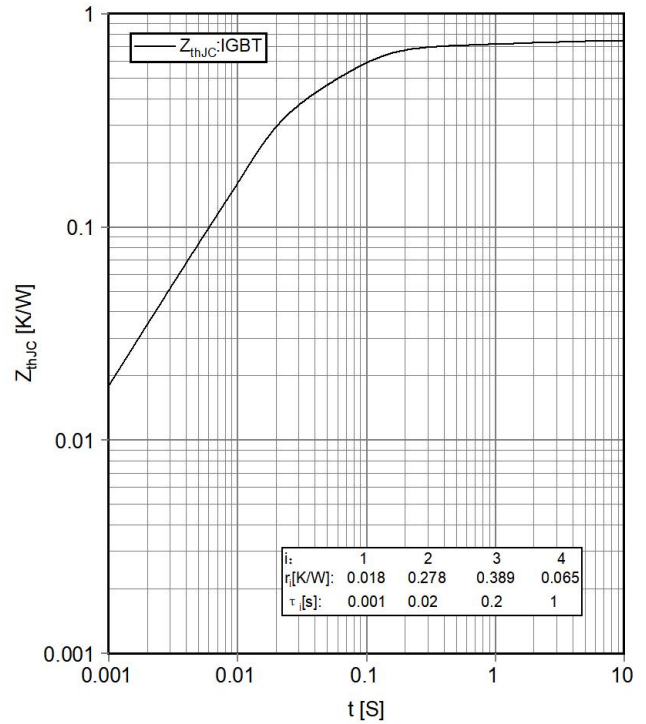
Switching losses IGBT, Inverter(typical)

$E_{on}=f(R_G)$, $E_{off}=f(R_G)$, $V_{GE}=\pm 15V$, $I_C=80A$, $V_{CE}=350V$



Transient thermal impedance IGBT, Inverter

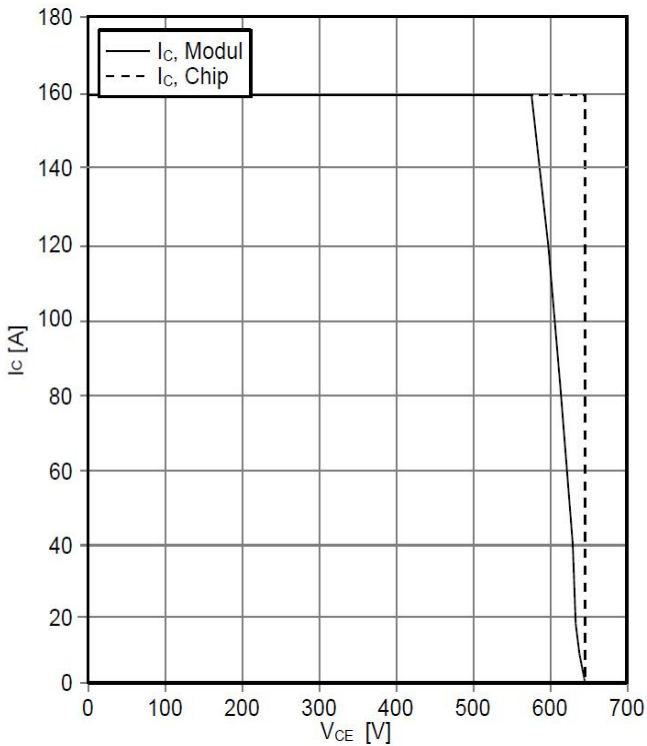
$Z_{thJC}=f(t)$



Reverse bias safe operating area IGBT, Inverter(RBSOA)

$I_C=f(V_{CE})$

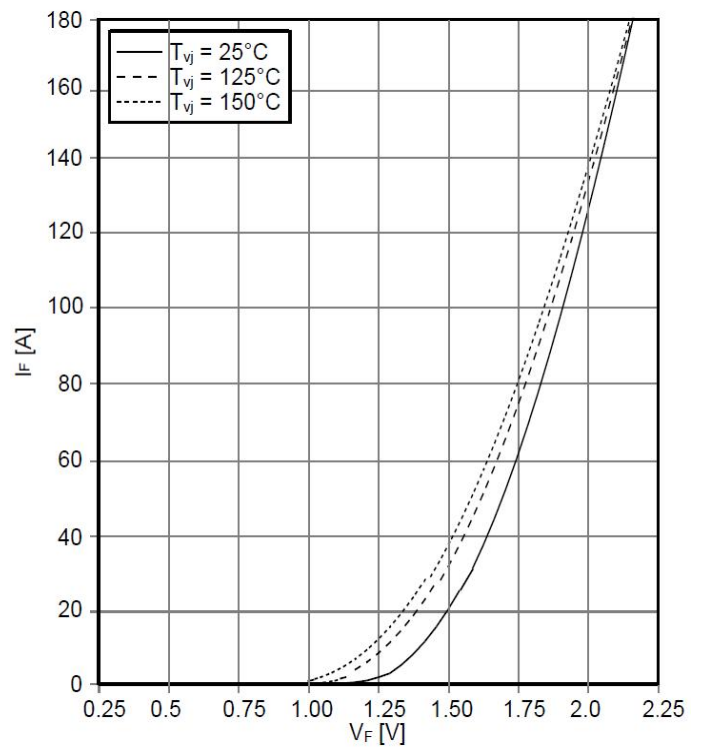
$V_{GE}=\pm 15V$, $R_{Goff}=12\Omega$, $T_{vj}=150^\circ C$



Capacity characteristic IGBT, Inverter (typical)

$C = f(V_{CE})$

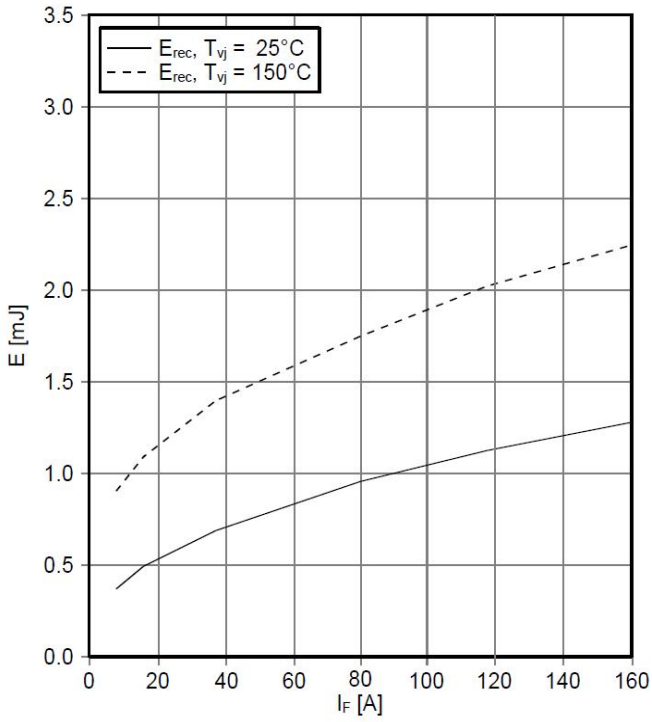
$V_{GE} = 0V$, $T_{vj} = 25^\circ C$, $f = 1MHz$



Gate charge characteristic IGBT Inverter (typical)

$V_{GE} = f(I_F)$

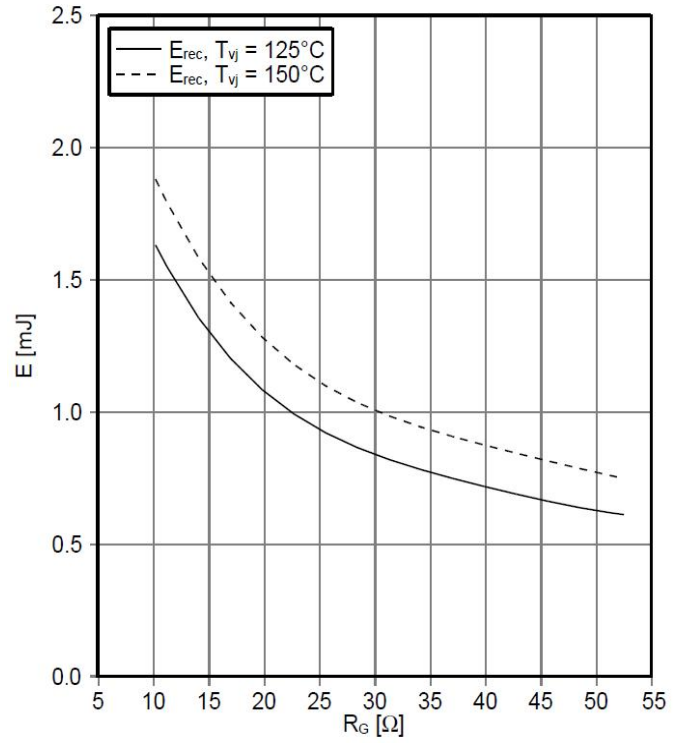
$R_{Gon} = 12 \Omega$, $V_{CE} = 350V$



Forward characteristic of Diode, Inverter (typical)

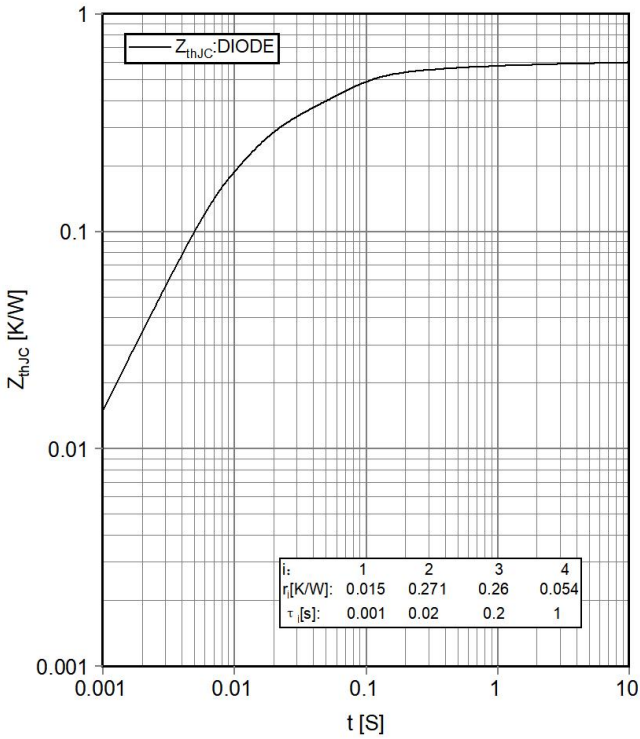
$E_{rec} = f(R_G)$

$I_F = 80A$, $V_{CE} = 350V$



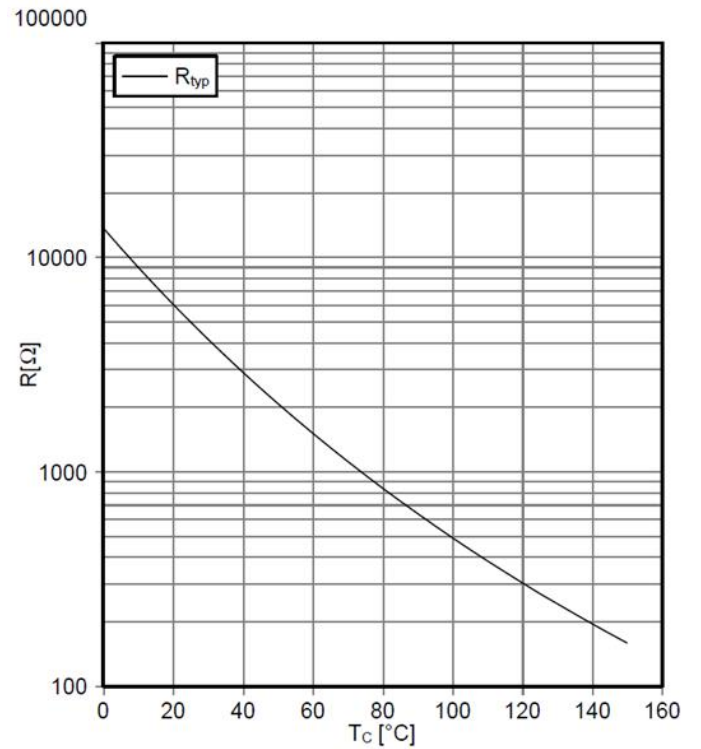
Transient thermal impedance Diode, Inverter

$Z_{thJC} = f(t)$

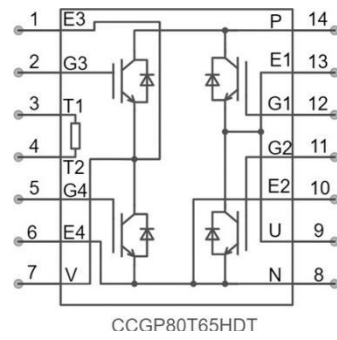
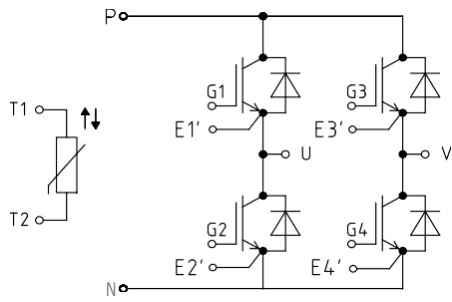


NTC-Thermistor-temperature characteristic (typical)

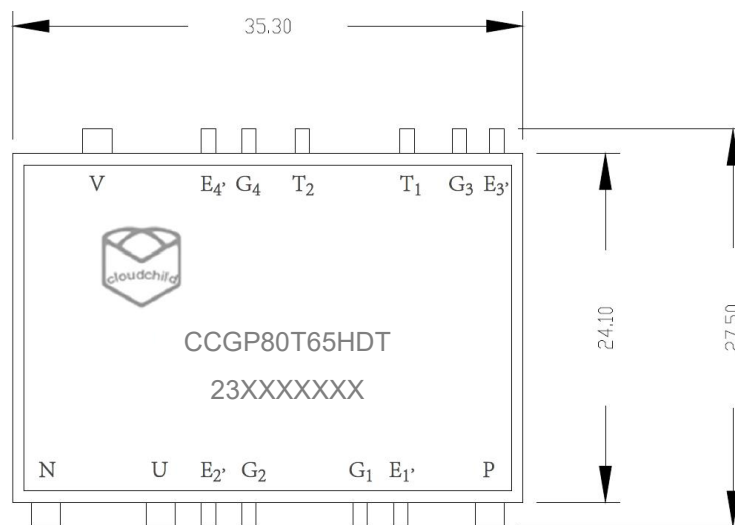
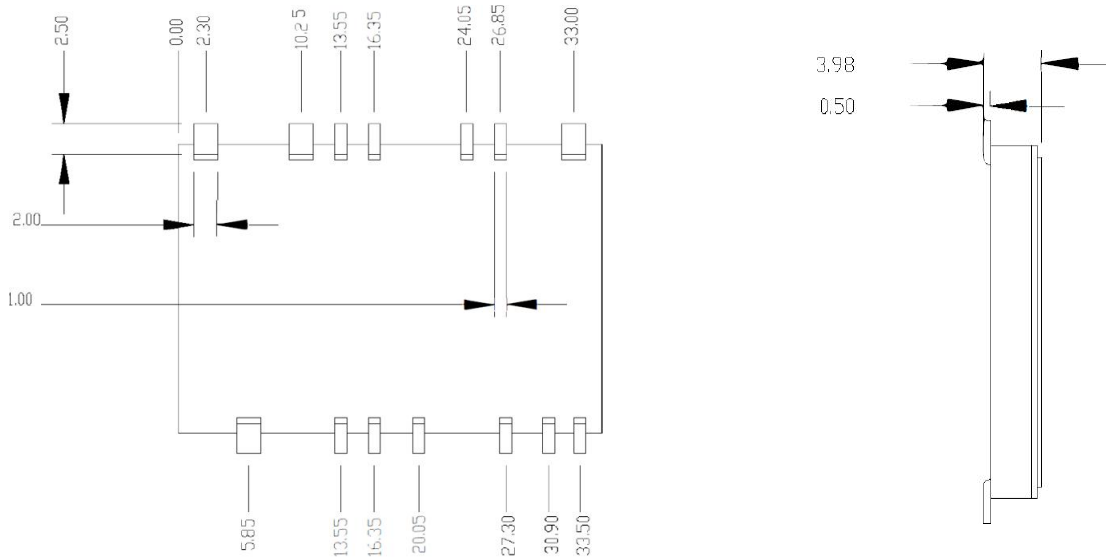
$R = f(T)$



circuit diagram headline



package outlines



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Date of change	Rev #	revise content
2023/09/25	A/0	/